



Unusually strong coherent response from grain-boundary Josephson network in polycrystalline $\text{Pr}_x\text{Y}_{1-x}\text{Ba}_2\text{Cu}_3\text{O}_{7-\delta}$

V.A.G. Rivera⁽¹⁾, C. Stari^(1,2), C.A. Cardoso⁽¹⁾, E. Marega⁽³⁾, S. Sergeenkov⁽¹⁾ and F.M. Araújo-Moreira^{(1)*}

⁽¹⁾ Grupo de Materiais e Dispositivos, Departamento de Física, UFSCar, Caixa Postal 676, 13565-905, São Carlos, SP, Brasil, email: faraujo@df.ufscar.br

⁽²⁾ Instituto de Física, Facultad de Ingeniería, Julio Herrera y Reissig 565, C.C. 30, 11000, Montevideo, Uruguay

⁽³⁾ Instituto de Física, U SP, Caixa Postal 369, 13560-970, São Carlos, SP, Brasil

Abstract – By applying a highly sensitive homemade AC susceptibility technique to $\text{Pr}_x\text{Y}_{1-x}\text{Ba}_2\text{Cu}_3\text{O}_{7-\delta}$ polycrystals (with $x=0.0, 0.1$ and 0.3), we observed a Fraunhofer type periodic dependence of the real part of the AC susceptibility at low magnetic fields. Using a single-plaquette approximation, we were able to successfully fit all the data assuming a strong coherent response from Josephson vortices penetrating intergranular regions of grain-boundary Josephson.

It is well-known [1] that important for large-scale applications properties of any realistic device based on Josephson effects require a very coherent response from many Josephson contacts comprising such a device. Usually [2], due to inevitable distribution of critical currents and sizes of the individual junctions, a grain-boundary induced Josephson network in polycrystalline materials manifests itself in a rather incoherent way, making it virtually impossible for applications. That is why, ordered (and more costly) artificially prepared Josephson junction arrays (JJAs) are used instead to achieve the expected performance [3]. In this Communication, we report on a clear evidence for unusually strong coherent response of grain-boundary Josephson network in our polycrystalline $\text{Pr}_x\text{Y}_{1-x}\text{Ba}_2\text{Cu}_3\text{O}_{7-\delta}$ (PYBCO) samples which manifest itself through a Fraunhofer type magnetic field dependence of the measured AC susceptibility.

A grain-boundary structure of YBCO sample, responsible for the observed unusually strong low-field AC response is clearly seen on the SEM scan (Fig.1). The onset temperatures $T_C(x)$ for all studied samples (independently confirmed via the resistivity, magnetization and AC susceptibility). The complex response $\chi_{ac} = \chi' + i\chi''$ was measured as a function of the AC field $h_{ac}(t) = h \cos(\omega t)$ taken at fixed temperature. The field dependence of the normalized real part of AC susceptibility $\Delta\chi'(h) = \chi'(h) - \chi'(0)$ for different temperatures and Pr content is shown in Fig.2. A pronounced Fraunhofer type form of the observed curves suggests a rather strong coherent response from many Josephson junctions comprising the grain-boundary network and hence the high quality of our samples. This experimental fact allows us to employ the so-called single-plaquette approximation [4] to describe the observed phenomenon. The best fits for the low-field region using $\chi'_j(h) = \frac{1}{2\pi} \int_0^{2\pi} d(\omega t) \left[\frac{\partial M_j(t)}{\partial h_{ac}(t)} \right] = \chi_0 J_0(f)$ (see fig. 2), where $M_j(t) = I_J(t)S/V$ (V is the properly defined volume),

$\chi_0 = 2\pi I_{c,j} S^2 / \Phi_0 V$, $J_0(f)$ is the Bessel function, $f = h/h_J$ ($h_J = \Phi_0 / 2\pi S$) is characteristic Josephson field. The authors gratefully acknowledge Brazilian agencies CNPq, CAPES and FAPESP for financial support.

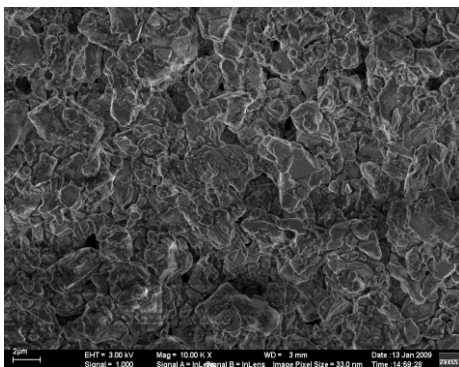


Figure 1: SEM scan photograph of polycrystalline $\text{YBa}_2\text{Cu}_3\text{O}_7$.

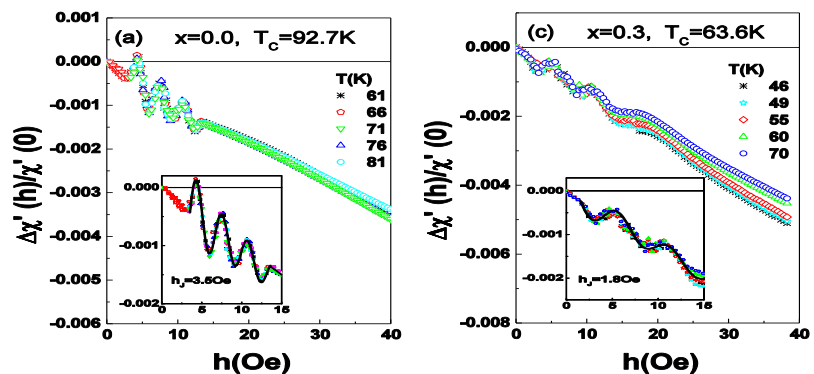


Figure 2: The magnetic field dependence of the normalized real part of AC susceptibility at different temperatures for samples with different Pr content: (a) $x=0.0$, (b) $x=0.3$. Inset: the best fits (solid line) of the low-field region according to Eq. (see above), using the Josephson field h_J as the only fitting parameter.

Reference

- [1] T.G. Zhou, L. Fang, S. Li, L. Ji, F.B. Song, M. He, X. Zhang, and S.L. Yan, IEEE Trans. Appl. Superc. 17, 586 (2007).
- [2] D.A. Balaev, A.A. Dubrovskiy, S.I. Popkov, K.A. Shaykhtudinov, and M.I. Petrov, J. Superc. 21, 243 (2008).
- [3] P. Martinoli and C. Leeman, J. Low Temp. Phys. 118, 699 (2000).
- [4] S. Sergeenkov, Phys. Lett. A 372, 2917 (2008).